PATENT COOPERATION TREATY

PCT

REC'D 2 6 APR 2006

WIPO

POT

INTERNATIONAL PRELIMINARY EXAMINATION REPORT

(PCT Article 36 and Rule 70)

Applicant's or agent's file reference FIN 572 PCT				FOR FURTHER ACTION See Notification of Transmittal of International Preliminary Examination Report (Form PCT/IPEA/416)					
International application No. PCT/IB2004/000272				International filing date (da 03.02.2004	ay/month/year)	Priority date (day/month/year) 03.02.2004			
	ational H01L			oth national classification an	d IPC				
Applicant									
INFI	INFINEON TECHNOLOGIES AG et al.								
1.	This i	ntern	ational preliminary exa	mination report has been applicant according to A	prepared by this Inte article 36.	ernational Preliminary Examining			
	Adiik	Jilly G	na lo tranomitos to une	о тррительного о					
	Thic	DEDC	NRT consists of a total	of 6 sheets, including thi	s cover sheet.				
2.	11115								
	This report is also accompanied by ANNEXES, i.e. sheets of the description, claims and/or drawings which have been amended and are the basis for this report and/or sheets containing rectifications made before this Authority (see Rule 70.16 and Section 607 of the Administrative Instructions under the PCT).					rectifications made before this Authority			
	Thes	•	exes consist of a total						
	11100								
	This		t contains indications r	elating to the following ite	oms.				
3.	Inis			elating to the following ite					
	- {		Basis of the opinion						
	II III		Priority	oninion with regard to no	ovelty inventive sten	and industrial applicability			
	III				opinion with regard to novelty, inventive step and industrial applicability				
	IV V		Lack of unity of inven	uon under Rule 66 2(a)(ii) wit	th regard to novelty, i	inventive step or industrial applicability;			
	V 🖾 Reasoned statement u citations and explanation			under Rule 66.2(a)(ii) with regard to novelty, inventive step or industrial applicability; ions supporting such statement					
	VI		Certain documents ci						
	VII			international application					
	VIII	\boxtimes	Certain observations	on the international appli	cation				
					Date of completion of	this report			
Date of submission of the demand			on of the demand		Date of completion of	uno repert			
10.06.2005				25.04.2006					
Name and mailing address of the international			onal	Authorized Officer					
preliminary examining authority: European Patent Office									
D-80298 Munich Tel. +49 89 2399 - 0 Tx: 523656 epmu d Fax: +49 89 2399 - 4465			3656 epmu d	Cousins, D	San				
				Telephone No. +49 8	9 2399-2759				

INTERNATIONAL PRELIMINARY EXAMINATION REPORT

International application No.

PCT/IB2004/000272

l.	Bas	is c	f th	ne r	eport
----	-----	------	------	------	-------

1. With regard to the **elements** of the international application (Replacement sheets which have been furnished to the receiving Office in response to an invitation under Article 14 are referred to in this report as "originally filed" and are not annexed to this report since they do not contain amendments (Rules 70.16 and 70.17)):

	Des	cription, Pages						
	1-15	, 19	as originally filed					
	Clai	ms, Numbers						
	1-18		received on 03.12.2005 with letter of 02.12.2005					
	Drav	wings, Sheets						
	1/4-4	1/4	as originally filed					
2.	With lang	ige , all the elements marked above were available or furnished to this Authority in the ernational application was filed, unless otherwise indicated under this item.						
	The	se elements were ava	ailable or furnished to this Authority in the following language: , which is:					
		the language of a tra	nslation furnished for the purposes of the international search (under Rule 23.1(b)).					
		the language of publi	cation of the international application (under Rule 48.3(b)).					
		the language of a tra Rule 55.2 and/or 55.3	nslation furnished for the purposes of international preliminary examination (under 3).					
3.	With inte	n regard to any nucle rnational preliminary e	otide and/or amino acid sequence disclosed in the international application, the examination was carried out on the basis of the sequence listing:					
		contained in the inter	rnational application in written form.					
		filed together with the	e international application in computer readable form.					
		furnished subsequer	ntly to this Authority in written form.					
		I furnished subsequently to this Authority in computer readable form.						
		in the international a	he subsequently furnished written sequence listing does not go beyond the disclosure pplication as filed has been furnished.					
		The statement that the listing has been furn	he information recorded in computer readable form is identical to the written sequence ished.					
4.	The	e amendments have r	esulted in the cancellation of:					
		the description,	pages:					
		the claims,	Nos.:					
		the drawings,	sheets:					

INTERNATIONAL PRELIMINARY EXAMINATION REPORT

International application No.

PCT/IB2004/000272

5.		This report has been establish been considered to go beyond	ed as I the di	if (some of) isclosure as	the amendments had not been made, since they have filed (Rule 70.2(c)).		
		(Any replacement sheet conta report.)	ining s	such amendr	ments must be referred to under item 1 and annexed to thi		
6.	Add	itional observations, if necessa	ry:				
III.	Nor	n-establishment of opinion w	ith reg	jard to nove	elty, inventive step and industrial applicability		
1.			uestions whether the claimed invention appears to be novel, to involve an inventive step (to be non- is), or to be industrially applicable have not been examined in respect of:				
		the entire international applica	tion,				
	\boxtimes	claims Nos. 11-18					
		because:					
		the said international application not require an international pre			ms Nos. relate to the following subject matter which does ion (specify):		
the description, claims or drawings (indicate particular elements below) or said claims Nos. are so und that no meaningful opinion could be formed (specify):							
		the claims, or said claims Nos could be formed.	. are s	o inadequate	ely supported by the description that no meaningful opinior		
	\boxtimes	no international search report	has be	een establish	ed for the said claims Nos. 11-18		
A meaningful international preliminary examination cannot be carried out due to the failure of th or amino acid sequence listing to comply with the standard provided for in Annex C of the Admi Instructions:							
		the written form has not been	furnish	ed or does r	not comply with the Standard.		
		the computer readable form ha	as not	been furnish	ed or does not comply with the Standard.		
٧.	Rea cita	soned statement under Artic tions and explanations supp	le 35(orting	2) with rega such state	rd to novelty, inventive step or industrial applicability; nent		
1.	Stat	Statement					
	Nov	elty (N)	Yes: No:	Claims Claims	8-10 1-7		
	Inve	entive step (IS)	Yes: No:	Claims Claims	9,10 8		
	Indu	ustrial applicability (IA)	Yes: No:	Claims Claims	1-10		

2. Citations and explanations

see separate sheet

INTERNATIONAL PRELIMINARY EXAMINATION REPORT

International application No.

PCT/IB2004/000272

VIII. Certain observations on the international application

The following observations on the clarity of the claims, description, and drawings or on the question whether the claims are fully supported by the description, are made:

see separate sheet

Section V

1. Reference is made to the following documents:

D1: US-A6114761 D2: US-A-6239486 D3: US-A-6259154

D4: EP-A-1172851

2. From D1 (see column 5, line 39 - column 7, line 2; Figures 2A, 5) a semiconductor package is known comprising:

a package substrate of the redistribution type having a flip-chip (18) mounted thereon;

a heatspreading means (50) comprising a planar area and at least one protrusion (54), the planar area being attached to the upper surface of the chip (18) and the protrusion being attached to the upper surface of the package substrate (16).

From the above-mentioned prior art it follows that the subject-matter of claims 1-7 is known from D1 (Article 33(2) PCT).

- 3. The additional feature of claim 8 is obvious from the prior art provided by D1 (Article 33(3) PCT).
- 4. The subject-matter of claim 9 essentially differs from that known from D1 in that:
 - a module-type heatspreading means is provided;
 - sawing grooves are provided in the above;
 - after attaching the heatspreading means to a substrate cpg a matrix of package sites having chips thereon, the individual semiconductor packages are singulated by using the sawing grooves.

The subject-matter of claim 9 is therefore new (Article 33(2) PCT).

The problem to be solved by the present invention may be regarded as providing a more economical and efficient production md.

The solution to this problem proposed in claim 9 of the present application is

considered as involving an inventive step (Article 33(3) PCT) for the following reasons:

D1 gives no hint to the skilled person to use batch manufacture.

D2 describes (see complete document) a cap for a flip-chip, the cap having side wall extending downward, openings being provided in the corners to permit air flow. There is no suggestion to use a batch manufacturing method in the sense of the present application.

D3 (see Figure 5 and accompanying description) describes a semiconductor device including a chip, TAB tape, stiffener, heat dissipation plate, whereby the latter may be provided in lead frame form. There is no disclosure of cutting at the final stage, nor would the skilled person obtain a hint from this document to do so.

D4 (see Figure 2D, Abstract) describes a batch manufacturing method using a heatspreader formed from a metal paste. The latter has no protruding portions and no grooves are provided therein. The skilled person would not be motivated to combine this teaching with that of D1.

For completeness it is pointed out that the subject-matter of claims 1,2,5 is known 5. from D2 (Article 33(2) PCT).

Section VIII

In claim 10 it is not clear whether the redistribution board is the same entity as the package substrate referred to in claim 9, both having the reference numeral "4".

10

15

AZ: FIN 572 PCT

16

Claims

- 1. A semiconductor package (1) comprising:
 - a semiconductor chip (2) including an active surface
 with a plurality of chip contact areas (3),
 - a package substrate (4) including a plurality of first contact areas (6) and a plurality of second contact areas (8) on its bottom surface, the chip (2) being mounted on the package substrate (4) with its active surface facing the package substrate (4),
 - a plurality of conducting means (5) providing electrical contact between the chip contact areas (3) and the first contact areas (6), and
 - a heat spreading means (10) comprising a planar area (11) and at least one protrusion (12), the planar area (11) being attached to the upper surface of the chip (2) and the protrusion (12) being attached to the upper surface of the package substrate (4).
- A semiconductor package according to claim 1
 characterized in that
 two protrusions (12) are provided, being located on opposite sides of the chip (2).
- 3. A semiconductor package according to claim 1 or claim 2 characterized in that the protrusions (12) are provided along the whole length of two opposing sides of the package substrate (4).
- 4. A semiconductor package according to one of claims 1 to 3 characterized in that two opposing sides of the package (1) are open.
 - 5. A semiconductor package according to one of claims 1 to 4

10

AZ: FIN 572 PCT

17

characterized in that open-ended air tunnels (17) extending from one side to the opposing side of the package (1) are formed between the chip (2), the heat spreading means (10) and the package substrate (4).

- 6. A semiconductor package according to one of claims 1 to 5 characterized in that the heat spreading means (10) is attached to the chip (2) by thermally conductive adhesive means (15) and to the package substrate (4) by non-conductive adhesive means (16).
- 7. A semiconductor package according to one of claims 1 to 6
 15 characterized in that
 the chip (2) is mounted to a redistribution board (4) using the flip-chip technique.
- 8. A semiconductor package according to one of claims 1 to 7
 20 characterized in that
 the surfaces of the heat spreading means (10, 19) are at
 least in part black.
- 9. A method to assemble a semiconductor package (1) comprising the following steps:
 - Providing a module heat spreading means (19) comprising:
 - a plurality of sawing grooves (18, 24) on its upper surface, and
 - a plurality of grooves (14) and protrusions (25) in its bottom surface,
 - Attaching thermally conductive adhesive means (15) to the grooves (14) and non-conductive adhesive means (16)

30

10

AZ: FIN 572 PCT

18

- to the protrusions (25) of the module heat spreading means (19),
- Providing a substrate (20) comprising a matrix of package sites (21) arranged in an array each including a chip (2) and a package substrate (4),
- Positioning the module heat spreading means (19) on the substrate (20) so that the protrusions (25) are in contact with the package substrates (4) of the substrate (20) and the groove (14) is connected to the upper passive surface of the chip (2),
- Curing the adhesive means,
- attaching a plurality of external contact means (9) to the contact areas (8) on the bottom surface of the package substrates (4) of the substrate (20),
- Singulating the individual semiconductor packages (1) by using the sawing grooves (18, 24) in the upper surface of the module heat spreading means (19) to guide the path of the saw blade.
- 20 10.A method to assemble a semiconductor package (1) according to claim 9 characterized in that the plurality of chips (2) are mounted using the flip-chip technique to a redistribution board (4) at each package site (21).
 - 11. Matrix package comprising:
 - a module heat spreading means (19) comprising:
 - a plurality of sawing grooves (18, 24) on its upper surface, and
 - a plurality of grooves (14) and protrusions (25) in its bottom surface,

30

AZ: FIN 572 PCT

19

- thermally conductive adhesive means (15) to the grooves (14) and non-conductive adhesive means (16) to the protrusions (25) of the module heat spreading means (19), and
- a substrate (20) comprising a matrix of package sites (21) arranged in an array each including a chip (2) and a package substrate (4),

wherein the module heat spreading means (19) is positioned on the substrate (20) so that the protrusions (25) are in contact with the package substrates (4) of the substrate (20) and the grooves (14) are connected to the upper passive surface of the chips (2).

- 12. Matrix package according to claim 11

 15 characterized in that
 the plurality of protrusions (25) are positioned approximately centrally between rows of chips (2).
- 13. Matrix package according to claim 11 or claim 12

 20 characterized in that
 the plurality of grooves (14) are positioned approximately parallel to each other.
- 14. Matrix package according to one of claims 11 to 13

 25 characterized in that
 the plurality of sawing grooves (18, 24) are arranged in a square grid array.
- 15. Matrix package according to one of claims 11 to 14
 30 characterized in that
 the package sites (21) are arranged in a square grid array.

AZ: FIN 572 PCT

20

- 16. Matrix package according to claim 14 or claim 15 characterized in that the sawing grooves (18, 24) are arranged in a square grid array which has approximately the same dimensions and orientation as the square grid array of the package sites (21).
- 17. Matrix package according to one of claims 11 to 16 characterized in that
- the module heat spreading means (19) is attached to the chip (2) by thermally conductive adhesive means (15) and to the package substrate (4) by non-conductive adhesive means (16).
- 18. Matrix package according to one of claims 11 to 17 characterized in that the chips (2) are mounted on the package sites (21) using a flip-chip technique.